# 6N134,\* 81028, HCPL-563X, HCPL-663X, HCPL-565X, 5962-98001, HCPL-268K, HCPL-665X, 5962-90855, HCPL-560X



Hermetically Sealed, High Speed, High CMR, Logic Gate Optocouplers

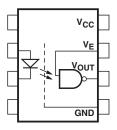
# **Data Sheet**

\*See matrix for available extensions.

# **Description**

These units are single, dual and quad channel, hermetically sealed optocouplers. The products are capable of operation and storage over the full military temperature range and can be purchased as either standard product or with full MIL-PRF-38534 Class Level H or K testing or from the appropriate DLA Drawing. All devices are manufactured and tested on a MIL-PRF-38534 certified line and are included in the DLA Qualified Manufacturers List QML-38534 for Hybrid Microcircuits. Quad channel devices are available by special order in the 16 pin DIP through hole packages.

## **Functional Diagram**



Multiple channel devices available

#### **Truth Table** (Positive Logic)

# **Multichannel Devices**

| Input   | Output |
|---------|--------|
| On (H)  | L      |
| Off (L) | Н      |

# **Single Channel DIP**

| Enable | Output |
|--------|--------|
| Н      | L      |
| Н      | Н      |
| L      | Н      |
| L      | Н      |
|        | •••    |

#### **Features**

- Dual marked with device part number and DLA drawing number
- Manufactured and tested on a MIL-PRF-38534 Certified Line
- QML-38534, Class H and K
- Five hermetically sealed package configurations
- Performance guaranteed over full military temperature range: -55°C to +125°C
- High speed: 10 Mbd typical
- CMR: > 10,000 V/μs typical
- 1500 Vdc withstand test voltage
- 2500 Vdc withstand test voltage for HCPL-565X
- High radiation immunity
- 6N137, HCPL-2601, HCPL-2630/31 function compatibility
- · Reliability data
- TTL circuit compatibility

## **Applications**

- Military and aerospace
- High reliability systems
- Transportation, medical, and life critical systems
- Line receiver
- Voltage level shifting
- Isolated input line receiver
- Isolated output line driver
- Logic ground isolation
- Harsh industrial environments
- Isolation for computer, communication, and test equipment systems

The connection of a 0.1  $\mu$ F bypass capacitor between  $V_{cc}$  and GND is recommended.

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

Each channel contains a GaAsP light emitting diode which is optically coupled to an integrated high speed photon detector. The output of the detector is an open collector Schottky clamped transistor. Internal shields provide a guaranteed common mode transient immunity specification of 1000 V/µs. For Isolation Voltage applications requiring up to 2500 Vdc, the HCPL-5650 family is also available. Package styles for these parts are 8 and 16 pin DIP through hole (case outlines P and E respectively), and 16 pin surface mount DIP flat pack (case outline F), leadless ceramic chip carrier (case outline 2). Devices may be purchased with a variety of lead bend and plating options. See Selection Guide Table for details. Standard Microcircuit Drawing (SMD) parts are available for each package and lead style.

Because the same electrical die (emitters and detectors) are used for each channel of each device listed in this data sheet, absolute maximum ratings, recommended operating conditions, electrical specifications, and performance characteristics shown in the figures are identical for all parts. Occasional exceptions exist due to package variations and limitations, and are as noted. Additionally, the same package assembly processes and materials are used in all devices. These similarities give justification for the use of data obtained from one part to represent other parts' performance for reliability and certain limited radiation test results.

## Selection Guide-Package Styles and Lead Configuration Options

| Package                 | 16 Pin DIP            | 8 Pin DIP    | 8 Pin DIP             | 8 Pin DIP             | 16 Pin Flat Pack      | 20 Pad LCCC   |
|-------------------------|-----------------------|--------------|-----------------------|-----------------------|-----------------------|---------------|
| Lead Style              | Through Hole          | Through Hole | Through Hole          | Through Hole          | Unformed Leads        | Surface Mount |
| Channels                | 2                     | 1            | 2                     | 2                     | 4                     | 2             |
| Common Channel Wiring   | V <sub>cc</sub> , GND | None         | V <sub>cc</sub> , GND | V <sub>cc</sub> , GND | V <sub>cc</sub> , GND | None          |
| Withstand Test Voltage  | 1500 Vdc              | 1500 Vdc     | 1500 Vdc              | 2500 Vdc              | 1500 Vdc              | 1500 Vdc      |
| Avago Part # & Options  |                       |              |                       |                       |                       |               |
| Commercial              | 6N134 <sup>[1]</sup>  | HCPL-5600    | HCPL-5630             | HCPL-5650             | HCPL-6650             | HCPL-6630     |
| MIL-PRF-38534, Class H  | 6N134/883B            | HCPL-5601    | HCPL-5631             | HCPL-5651             | HCPL-6651             | HCPL-6631     |
| MIL-PRF-38534, Class K  | HCPL-268K             | HCPL-560K    | HCPL-563K             |                       | HCPL-665K             | HCPL-663K     |
| Standard Lead Finish    | Gold Plate            | Gold Plate   | Gold Plate            | Gold Plate            | Gold Plate            | Solder Pads*  |
| Solder Dipped*          | Option #200           | Option #200  | Option #200           | Option #200           |                       |               |
| Butt Cut/Gold Plate     | Option #100           | Option #100  | Option #100           |                       |                       |               |
| Gull Wing/Soldered*     | Option #300           | Option #300  | Option #300           |                       |                       |               |
| Class H SMD Part #      |                       |              |                       |                       |                       |               |
| Prescript for all below | None                  | 5962-        | None                  | None                  | None                  | None          |
| Gold Plate              | 8102801EC             | 9085501HPC   | 8102802PC             | 8102805PC             | 8102804FC             |               |
| Solder Dipped*          | 8102801EA             | 9085501HPA   | 8102802PA             | 8102805PA             |                       | 81028032A     |
| Butt Cut/Gold Plate     | 8102801UC             | 9085501HYC   | 8102802YC             |                       |                       |               |
| Butt Cut/Soldered*      | 8102801UA             | 9085501HYA   | 8102802YA             |                       |                       |               |
| Gull Wing/Soldered*     | 8102801TA             | 9085501HXA   | 8102802ZA             |                       |                       |               |
| Class K SMD Part #      |                       |              |                       |                       |                       |               |
| Prescript for all below | 5962-                 | 5962-        | 5962-                 |                       | 5962-                 | 5962-         |
| Gold Plate              | 9800101KEC            | 9085501KPC   | 9800102KPC            |                       | 9800104KFC            |               |
| Solder Dipped*          | 9800101KEA            | 9085501KPA   | 9800102KPA            |                       |                       | 9800103K2A    |
| Butt Cut/Gold Plate     | 9800101KUC            | 9085501KYC   | 9800102KYC            |                       |                       |               |
| Butt Cut/Soldered*      | 9800101KUA            | 9085501KYA   | 9800102KYA            |                       |                       |               |
| Gull Wing/Soldered*     | 9800101KTA            | 9085501KXA   | 9800102KZA            |                       |                       |               |

<sup>\*</sup>Solder contains lead.

#### Note:

1. JEDEC registered part.

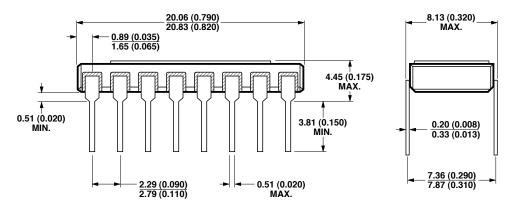
# **Functional Diagrams**

| 16 Pin DIP   | 8 Pin DIP  | 8 Pin DIP            | 16 Pin Flat Pack   | 20 Pad LCCC   |
|--|--|----------------------|--|---|
| Through Hole   | Through Hole   | Through Hole         | Unformed Leads   | Surface Mount   |
| 2 Channels   | 1 Channel  | 2 Channels           | 4 Channels   | 2 Channels  |
| 1 16 2 VCC 15 3 V01 14 4 13 5 V02 12 6 11 7 GND 10 8 9 | 1 V <sub>CC</sub> 8  2 V <sub>E</sub> 7  3 Vout 6  4 GND 5 | V <sub>CC</sub> 8  2 | 16 2 VCC 15 3 V01 14 4 V02 13 5 V03 12 6 V04 11 7 GND 10 8 | 15<br>V <sub>CC2</sub><br>19<br>20<br>V <sub>O2</sub><br>13<br>12<br>V <sub>CC1</sub><br>13<br>12<br>V <sub>CC1</sub><br>10<br>MD <sub>2</sub><br>10<br>V <sub>CC1</sub><br>10<br>MD <sub>2</sub><br>11<br>10<br>10<br>10<br>10<br>10<br>10<br>10<br>10<br>10<br>10<br>10<br>10 |

**Note:** All DIP and flat pack devices have common  $V_{cc}$  and ground. Single channel DIP has an enable pin 7. LCCC (leadless ceramic chip carrier) package has isolated channels with separate  $V_{cc}$  and ground connections. All diagrams are "top view."

# **Outline Drawings**

# 16 Pin DIP Through Hole, 2 Channels



NOTE: DIMENSIONS IN MILLIMETERS (INCHES).

# **Leaded Device Marking**



\* QUALIFIED PARTS ONLY

# **Leadless Device Marking**



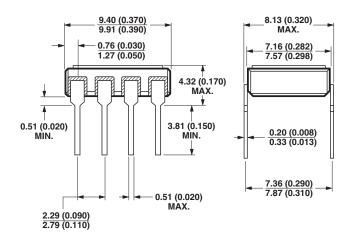
\* QUALIFIED PARTS ONLY

Notes

1. Qualified parts only

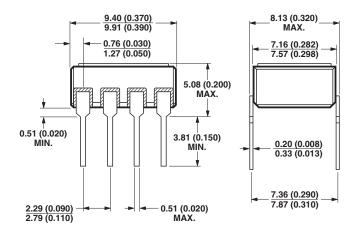
# **Outline Drawings (continued)**

## 8 Pin DIP Through Hole, 1 and 2 Channels



NOTE: DIMENSIONS IN MILLIMETERS (INCHES).

# 8 Pin DIP Through Hole, 2 Channels 2500 Vdc Withstand Test Voltage



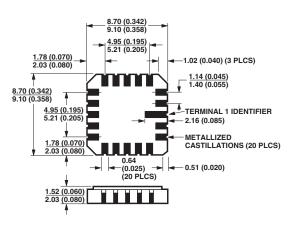
NOTE: DIMENSIONS IN MILLIMETERS (INCHES).

#### 16 Pin Flat Pack, 4 Channels

# 7.24 (0.285) 6.99 (0.275) 2.29 (0.090) MÀX. 11.13 (0.438) 10.72 (0.422) 1.27 (0.050) RÈF. 0.46 (0.018) 0.36 (0.014) 8.13 (0.320) 2.85 (0.112) MAX. 0.31 (0.012) 0.23 (0.009) 0.88 (0.0345) MIN. 5.23 0.89 (0.035) 0.69 (0.027) 9.02 (0.355) 8.76 (0.345) (0.206) MAX.

NOTE: DIMENSIONS IN MILLIMETERS (INCHES).

#### 20 Terminal LCCC Surface Mount, 2 Channels



NOTE: DIMENSIONS IN MILLIMETERS (INCHES). SOLDER THICKNESS 0.127 (0.005) MAX.

# **Hermetic Optocoupler Options**

# **Option** Description 100 Surface mountable hermetic optocoupler with leads trimmed for butt joint assembly. This option is available on commercial and hi-rel product in 8 and 16 pin DIP (see drawings below for details). 4.32 (0.170) 0.51 (0.020) MIN. 1.14 (0.045) 1.40 (0.055) 2.29 (0.090) 2.79 (0.110) 0.51 (0.020) MAX. 4.32 (0.170) 0.51 (0.020) 1.14 (0.045) 1.40 (0.055) 0.20 (0.008) 0.33 (0.013) 0.51 (0.020) MAX. 2.29 (0.090) 2.79 (0.110) 7.36 (0.290) 7.87 (0.310) NOTE: DIMENSIONS IN MILLIMETERS (INCHES). 200 Lead finish is solder dipped rather than gold plated. This option is available on commercial and hi-rel product in 8 and 16 pin DIP. DLA Drawing part numbers contain provisions for lead finish. All leadless chip carrier devices are delivered with solder dipped terminals as a standard feature. 300 Surface mountable hermetic optocoupler with leads cut and bent for gull wing assembly. This option is available on commercial and hi-rel product in 8 and 16 pin DIP (see drawings below for details). This option has solder dipped leads. 4.57 (0.180) 0.51 (0<sup>'</sup>.020) MIN. 1.40 (0.055) 1.65 (0.065) 0.51 (0.020) MAX. 2.29 (0.090) 2.79 (0.110) 4.57 (0.180) 4.57 (0.180) 0.20 (0.008) 0.33 (0.013) 0.51 (0.020) 5° MAX. 1.40 (0.055) 1.65 (0.065) 1.07 (0.042) MIN. 1.32 (0.052) 9.65 (0.380) 9.91 (0.390) 0.51 (0.020) MAX. 2.29 (0.090) 2.79 (0.110) NOTE: DIMENSIONS IN MILLIMETERS (INCHES).

Solder contains lead.

# **Absolute Maximum Ratings**

No derating required up to +125°C.

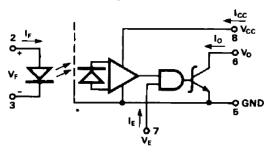
| Parameter  | Symbol               | Min. | Max.           | Units |
|--|----------------------|------|----------------|-------|
| Storage Temperature  | T <sub>s</sub>       | -65  | +150           | °C    |
| Operating Temperature  | T <sub>A</sub>       | -55  | +125           | °C    |
| Case Temperature   | T <sub>C</sub>       |      | +170           | °C    |
| Junction Temperature   | T <sub>J</sub>       |      | +175           | °C    |
| Lead Solder Temperature                                      |                      |      | 260 for 10 sec | °C    |
| Peak Forward Input Current<br>(each channel, ≤1 ms duration) | I <sub>F(PEAK)</sub> |      | 40             | mA    |
| Average Input Forward Current (each channel)                 | I <sub>F(AVG)</sub>  |      | 20             | mA    |
| Input Power Dissipation (each channel)                       |                      |      | 35             | mW    |
| Reverse Input Voltage (each channel                          | V <sub>R</sub>       |      | 5              | V     |
| Supply Voltage (1 minute maximum)                            | V <sub>cc</sub>      |      | 7.0            | V     |
| Output Current (each channel)                                | I <sub>o</sub>       |      | 25             | mA    |
| Output Voltage (each channel)                                | V <sub>o</sub>       |      | 7*             | V     |
| Output Power Dissipation (each channel)                      | P <sub>o</sub>       |      | 40             | mW    |
| Package Power Dissipation (each channel)                     | P <sub>D</sub>       |      | 200            | mW    |

<sup>\*</sup>Selection for higher output voltages up to 20 V is available

# **Single Channel Product Only**

| Enable Input Voltage | V <sub>E</sub> | 5.5 | V |
|----------------------|----------------|-----|---|

# **8 Pin Ceramic DIP Single Channel Schematic**



Note enable pin 7. An external 0.01  $\mu F$  to 0.1  $\mu F$  bypass capacitor must be connected between  $V_{cc}$  and ground for each package type.

# **ESD Classification**

(MIL-STD-883, Method 3015)

| HCPL-5600/01/0K   | ( <b>▲</b> ), Class 1 |
|---|-----------------------|
| 6N134, 6N134/883B, HCPL-5630/31/3K, HCPL-5650/51, HCPL-6630/31/3K and HCPL-6650/51/5K | (Dot), Class 3        |

# **Recommended Operating Conditions**

| Parameter                                | Symbol          | Min. | Max. | Units |
|--|-----------------|------|------|-------|
| Input Current, Low Level, Each Channel   | I <sub>FL</sub> | 0    | 250  | μΑ    |
| Input Current, High Level, Each Channel* | I <sub>FH</sub> | 10   | 20   | mA    |
| Supply Voltage, Output                   | V <sub>cc</sub> | 4.5  | 5.5  | V     |
| Fan Out (TTL Load) Each Channel          | N               |      | 6    |       |

<sup>\*</sup>Meets or exceeds DLA SMD and JEDEC requirements.

# Recommended Operating Conditions (cont'd.)

Single Channel Product Only<sup>[10]</sup>

| Parameter                 | Symbol          | Min. | Max.            | Units |
|---------------------------|-----------------|------|-----------------|-------|
| High Level Enable Voltage | V <sub>EH</sub> | 2.0  | V <sub>cc</sub> | V     |
| Low Level Enable Voltage  | V <sub>EL</sub> | 0    | 0.8             | V     |

# Electrical Characteristics ( $T_A = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , unless otherwise specified)

|                        |   |                    |  |   | Group                         |      | Limits |      |          |      |             |
|------------------------|---|--------------------|--|---|-------------------------------|------|--------|------|----------|------|-------------|
| Parametei              |   | Symbol             | Test Condition   | ons   | A <sup>[13]</sup> Sub- groups | Min. | Тур.** | Max. | Units    | Fig. | Note        |
| High Leve              |   | I <sub>OH</sub> *  | $V_{CC} = 5.5 \text{ V}, V_{CC} = 250  \mu\text{A}$          | $V_0 = 5.5  \text{V},$                            | 1, 2, 3                       |      | 20     | 250  | μΑ       | 1    | 1           |
| Low Leve<br>Output Vo  |   | V <sub>OL</sub> *  | $V_{CC} = 5.5 \text{ V},$<br>$I_{OL} \text{ (Sinking)}$      |   | 1, 2, 3                       |      | 0.3    | 0.6  | V        | 2    | 1, 9        |
| Current T<br>Ratio     | ransfer   | h <sub>F</sub> CTR | $V_{o} = 0.6 \text{ V, I}$<br>$V_{cc} = 5.5 \text{ V}$       | <sub>F</sub> = 10 mA,                             | 1, 2, 3                       | 100  |        |      | %        |      | 1           |
| Logic<br>High          | Single<br>Channel   | I <sub>CCH</sub> * | $V_{cc} = 5.5 \text{ V},$                                    | $I_F = 0 \text{ mA}$                              | 1, 2, 3                       |      | 9      | 14   | mA       |      | 1           |
| Supply<br>Current      | Dual<br>Channel   |                    | $V_{CC} = 5.5 \text{ V},$<br>$I_{F1} = I_{F2} = 0 \text{ r}$ | mA  |                               |      | 18     | 28   | mA       |      | 6           |
|                        | Quad<br>Channel   |                    | $V_{CC} = 5.5 \text{ V},$<br>$I_{F3} = I_{F4} = 0 \text{ r}$ |   |                               |      | 25     | 42   | mA       |      |             |
| Logic<br>low           | low Channel Supply Dual   | I <sub>CCL</sub> * | $V_{cc} = 5.5 \text{ V},$<br>$I_{F} = 20 \text{ mA}$         | $V_{cc} = 5.5 \text{ V},$ $I_{F} = 20 \text{ mA}$ |                               |      | 13     | 18   | mA       |      | 1           |
| Supply<br>Current      |   |                    | $V_{CC} = 5.5 \text{ V},$<br>$I_{F1} = I_{F2} = 20$          | mA  |                               |      | 26     | 36   | mA       |      | 6           |
| Quad<br>Channel        |   |                    | $V_{CC} = 5.5 \text{ V},$<br>$I_{F3} = I_{F4} = 20$          |   |                               |      | 33     | 50   | mA       |      |             |
| Input For              | ward  | V <sub>F</sub> *   | $I_{F} = 20 \text{ mA}$                                      |   | 1, 2, 3                       |      | 1.5    | 1.9  | V        | 3    | 1, 15       |
| Voltage                | Voltage   |                    |  |   | 1, 2                          |      | 1.55   | 1.75 | V        | 3    | 1, 16       |
|                        |   |                    |  |   | 3                             |      |        | 1.85 |          |      |             |
| Input Rev<br>Breakdow  | erse<br>'n Voltage  | BV <sub>R</sub> *  | $I_R = 10 \mu A$   | $I_R = 10 \mu A$                                  |                               | 5    |        |      | V        |      | 1           |
|                        | nput-Output $I_{l-O}^*$ $RH \le 65\%$ $V_{l-O} = 1500$<br>eakage Current $T_A = 25^{\circ}\text{C}$ $Vdc$ |                    | 1  |   |                               | 1.0  | μΑ     |      | 2, 8, 17 |      |             |
|                        |   |                    | t = 5 s  | V <sub>I-O</sub> = 2500<br>Vdc                    | 1                             |      |        | 1.0  | μΑ       |      | 18          |
| Capacitar<br>Input/ Ou | ce Between<br>tput  | C <sub>I-O</sub>   | f = 1 MHz, T   | <sub>c</sub> = 25°C                               | 4                             |      | 1.0    | 4.0  | pF       |      | 1, 3,<br>14 |

<sup>\*</sup>Identified test parameters for JEDEC registered parts. \*\*All typical values are at  $V_{\rm CC} = 5$  V,  $T_{\rm A} = 25$  °C.

# Electrical Characteristics, (cont'd) $T_A = -55$ °C to +125°C unless otherwise specified

|   |                    |  | Group A <sup>[13]</sup> |      | Limits |      |       |         |             |
|---|--------------------|--|-------------------------|------|--------|------|-------|---------|-------------|
| Parameter   | Symbol             | Test Conditions  | Subgroups               | Min. | Тур.** | Max. | Units | Fig.    | Note        |
| Propagation Delay   | t <sub>PLH</sub> * | $V_{CC} = 5 \text{ V, R}_{L} = 510 \Omega,$  | 9                       |      | 60     | 100  | ns    | 4, 5, 6 | 1, 5        |
| Time to High Output<br>Level                                    |                    | $C_{L} = 50 \text{ pF},$<br>$I_{F} = 13 \text{ mA}$  | 10, 11                  |      |        | 140  |       |         |             |
| Propagation Delay   | t <sub>PHL</sub> * |  | 9                       |      | 55     | 100  | ns    |         |             |
| Time to Low Output<br>Level                                     |                    |  | 10, 11                  |      |        | 120  |       |         |             |
| Output Rise Time  | t <sub>LH</sub>    | $R_{L} = 510 \Omega, C_{L} = 50$   | 9, 10, 11               |      | 35     | 90   | ns    |         | 1           |
| Output Fall Time  | t <sub>HL</sub>    | pF, I <sub>F</sub> = 13 mA   |                         |      | 35     | 40   |       |         |             |
| Common Mode<br>Transient<br>Immunity at<br>High Output<br>Level | CM <sub>H</sub>    | $V_{CM} = 50 \text{ V (PEAK)},$<br>$V_{CC} = 5 \text{ V},$<br>$V_{O} \text{ (min.)} = 2 \text{ V},$<br>$R_{L} = 510 \Omega,$<br>$I_{F} = 0 \text{ mA}$ | 9, 10, 11               | 1000 | >10000 |      | V/µs  | 7       | 1, 7,<br>14 |
| Common Mode<br>Transient<br>Immunity at Low<br>Output Level     | CM <sub>L</sub>    | $V_{CM} = 50 \text{ V (PEAK)},$<br>$V_{CC} = 5 \text{ V, } V_{O} \text{ (max.)} = 0.8 \text{ V, } R_{L} = 510 \Omega, I_{F} = 10 \text{ mA}$           | 9, 10, 11               | 1000 | >10000 |      | V/µs  | 7       | 1, 7,<br>14 |
| Single Channel Product  | Only               |  |                         |      |        |      |       |         |             |
| Low Level<br>Enable Current                                     | I <sub>EL</sub>    | $V_{CC} = 5.5 \text{ V},$<br>$V_{E} = 0.5 \text{ V}$   | 1, 2, 3                 | -2.0 | -1.45  |      | mA    |         |             |
| High Level  | V <sub>EH</sub>    |  | 1, 2, 3                 | 2.0  |        |      | V     |         | 10          |

# Typical Characteristics, $T_A = 25^{\circ}\text{C}$ , $V_{cc} = 5\text{ V}$

| Parameter                              | Sym.                                      | Тур. | Units | Test Conditions                         | Fig. | Note |
|--|---|------|-------|---|------|------|
| Input Capacitance                      | C <sub>IN</sub>                           | 60   | pF    | $V_F = 0 \text{ V, } f = 1 \text{ MHz}$ |      | 1    |
| Input Diode Temperature<br>Coefficient | $\Delta V_{\rm F} \over \Delta T_{\rm A}$ | -1.5 | mV/°C | I <sub>F</sub> = 20 mA                  |      | 1    |
| Resistance (Input-Output)              | R <sub>I-O</sub>                          | 1012 | Ω     | V <sub>I-O</sub> = 500 V                |      | 2    |

1, 2, 3

0.8

# **Single Channel Product Only**

**Enable Voltage** Low Level

**Enable Voltage** 

| Propagation Delay Time of        | t <sub>ELH</sub> | 35 | ns | $R_1 = 510 \Omega, C_1 = 50 pF$              | 8, 9 | 1, 11 |
|----------------------------------|------------------|----|----|--|------|-------|
| Enable from $V_{EH}$ to $V_{EL}$ |                  |    |    | $I_F = 13 \text{ mA}, V_{EH} = 3 \text{ V},$ |      |       |
| Propagation Delay Time of        | t <sub>EHL</sub> | 35 | ns | $V_{EL} = 0V$                                |      | 1, 12 |
| Enable from $V_{EL}$ to $V_{EH}$ |                  |    |    |  |      |       |

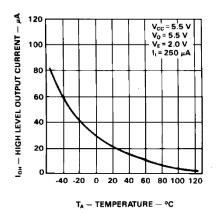
# **Dual and Quad Channel Product Only**

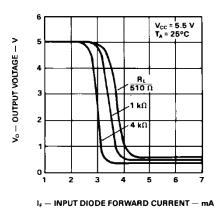
| Input-Input<br>Leakage Current | I <sub>I-I</sub> | 0.5  | nA | Relative Humidity $\leq$ 65% $V_{I-I} = 500 \text{ V}, t = 5 \text{ s}$ | 4 |
|--------------------------------|------------------|------|----|---|---|
| Resistance (Input-Input)       | R <sub>I-I</sub> | 1012 | Ω  | V <sub>I-I</sub> = 500 V  | 4 |
| Capacitance (Input-Input)      | C <sub>I-I</sub> | 0.55 | pF | f = 1 MHz   | 4 |

<sup>\*</sup>Identified test parameters for JEDEC registered part. \*\*All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25 ^{\circ}\text{C}$ .

#### Notes:

- 1. Each channel.
- 2. All devices are considered two-terminal devices; I<sub>LO</sub> is measured between all input leads or terminals shorted together and all output leads or terminals shorted together.
- 3. Measured between each input pair shorted together and all output connections for that channel shorted together.
- 4. Measured between adjacent input pairs shorted together for each multichannel device.
- 5. t<sub>PHL</sub> propagation delay is measured from the 50% point on the leading edge of the input pulse to the 1.5 V point on the leading edge of the output pulse. The t<sub>PLH</sub> propagation delay is measured from the 50% point on the trailing edge of the input pulse to the 1.5 V point on the trailing edge of the output pulse.
- 6. The HCPL-6630, HCPL-6631, and HCPL-663K dual channel parts function as two independent single channel units. Use the single channel parameter limits for each channel.
- 7.  $CM_L$  is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic low state ( $V_O < 0.8 \text{ V}$ ).  $CM_H$  is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic high state ( $V_O > 2.0 \text{ V}$ ).
- 8. This is a momentary withstand test, not an operating condition.
- 9. It is essential that a bypass capacitor (0.01 to 0.1  $\mu$ F, ceramic) be connected from  $V_{cc}$  to ground. Total lead length between both ends of this external capacitor and the isolator connections should not exceed 20 mm.
- 10. No external pull up is required for a high logic state on the enable input.
- 11. The t<sub>ELH</sub> enable propagation delay is measured from the 1.5 V point on the trailing edge of the enable input pulse to the 1.5 V point on the trailing edge of the output pulse.
- 12. The t<sub>EHL</sub> enable propagation delay is measured from the 1.5 V point on the leading edge of the enable input pulse to the 1.5 V point on the leading edge of the output pulse.
- 13. Standard parts receive 100% testing at 25°C (Subgroups 1 and 9). SMD and 883B parts receive 100% testing at 25, 125, and -55°C (Subgroups 1 and 9, 2 and 10, 3 and 11, respectively).
- 14. Parameters are tested as part of device initial characterization and after design and process changes. Parameters are guaranteed to limits specified for all lots not specifically tested.
- 15. Not required for 6N134, 6N134/883B, 8102801, HCPL-268K and 5962-9800101 types.
- 16. Required for 6N134, 6N134/883B, 8102801, HCPL-268K and 5962-9800101 types.
- 17. Not required for HCPL-5650, HCPL-5651 and 8102805 types.
- 18. Required for HCPL-5650, HCPL-5651 and 8102805 types only.





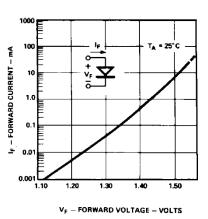
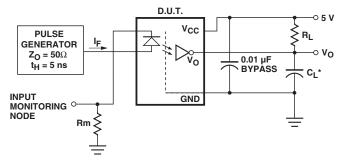


Figure 1. High Level Output Current vs. Temperature.

Figure 2. Input-Output Characteristics.

Figure 3. Input Diode Forward Characteristics.



\* CLINCLUDES PROBE AND STRAY WIRING CAPACITANCE.

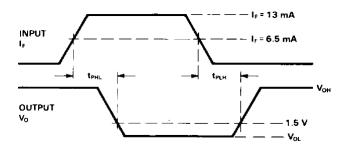


Figure 4. Test Circuit for  $t_{\rm PHL}$  and  $t_{\rm PLH}$ .\*

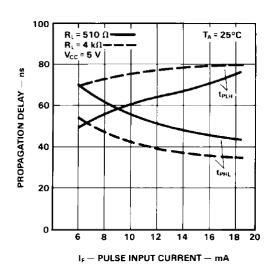


Figure 5. Propagation Delay,  $\mathbf{t_{_{PHL}}}$  and  $\mathbf{t_{_{PLH}}}$  vs. Pulse Input Current,  $\mathbf{I_{_{FH}}}$  .

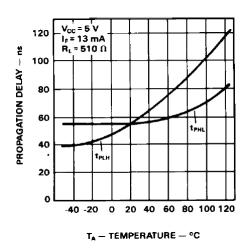


Figure 6. Propagation Delay vs. Temperature.

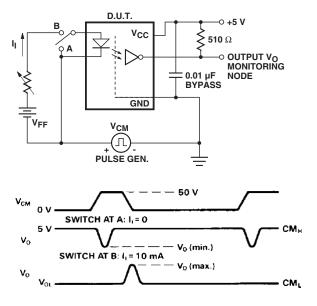


Figure 7. Test Circuit for Common Mode Transient Immunity and Typical Waveforms.

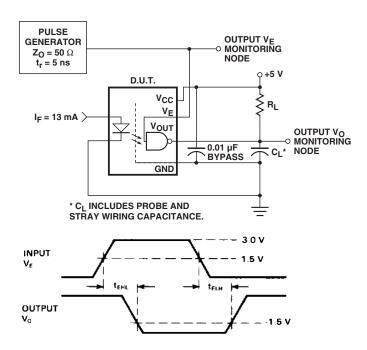


Figure 8. Test Circuit for  $\mathbf{t}_{\text{\tiny EHL}}$  and  $\mathbf{t}_{\text{\tiny ELH}}.$ 

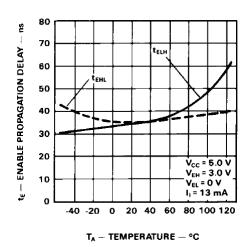
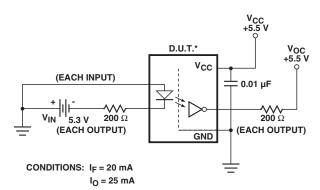


Figure 9. Enable Propagation Delay vs. Temperature.



T<sub>A</sub> = +125 °C

Figure 10. Operating Circuit for Burn-In and Steady State Life Tests.

<sup>\*</sup> ALL CHANNELS TESTED SIMULTANEOUSLY.

# MIL-PRF-38534 Class H, Class K, and DLA SMD Test Program

Avago's Hi-Rel Optocouplers are in compliance with MIL-PRF-38534 Classes H and K. Class H and Class K devices are also in compliance with DLA drawings 81028, 5962-90855 and 5962-98001.

Testing consists of 100% screening and quality conformance inspection to MIL-PRF-38534.

For product information and a complete list of distributors, please go to our website: **www.avagotech.com** 



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